



APT25GR120BSCD10 APT25GR120SSCD10

1200V, 25A, $V_{CE(on)}$ = 2.5V Typical

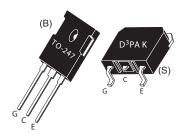
Ultra Fast NPT - IGBT®

The Ultra Fast NPT - IGBT® is a new generation of high voltage power IGBTs. Using Non-Punch-Through Technology, the Ultra Fast NPT-IGBT® offers superior ruggedness and ultrafast switching speed.

Features

- · Low Saturation Voltage
- Low Tail Current
- RoHS Compliant

- · Short Circuit Withstand Rated
- High Frequency Switching
- Ultra Low Leakage Current



Combi (IGBT and Diode)

All Ratings: T_C = 25°C unless otherwise specified.

300



Unless stated otherwise, Microsemi discrete IGBTs contain a single IGBT die. This device is recommended for applications such as induction heating (IH), motor control, general purpose inverters and uninterruptible power supplies (UPS).

MAXIMUM RATINGS

Symbol	Parameter	Ratings	Unit
V _{ces}	Collector Emitter Voltage	1200	V
$V_{\rm GE}$	Gate-Emitter Voltage	±30] ^v
I _{C1}	Continuous Collector Current @ T _c = 25°C	75	
I _{C2}	Continuous Collector Current @ T _C = 125°C	25	Α
I _{CM}	Pulsed Collector Current ①	100	1
SCWT	Short Circuit Withstand Time: V _{CE} = 600V, V _{GE} = 15V, T _C =125°C	10	μs
P _D	Total Power Dissipation @ T _c = 25°C	521	W
T _J ,T _{STG}	Operating and Storage Junction Temperature Range	-55 to 150	°C
			7 C

STATIC ELECTRICAL CHARACTERISTICS

Max. Lead Temp. for Soldering: 0.063" from Case for 10 Sec.

Symbol	Parameter	Min	Тур	Max	Unit
V _{(BR)CES}	Collector-Emitter Breakdown Voltage $(V_{GE} = 0V, I_{C} = 500\mu\text{A})$	1200			
V _{GE(TH)}	Gate Threshold Voltage $(V_{CE} = V_{GE}, I_{C} = 1.0 \text{mA}, T_{j} = 25 ^{\circ}\text{C})$	3.5	5.0	6.5	1/-14-
V _{CE(ON)}	Collector-Emitter On Voltage (V _{GE} = 15V, I _C = 25A, T _j = 25°C)		2.5	3.2	Volts
	Collector-Emitter On Voltage (V _{GE} = 15V, I _C = 25A, T _j = 125°C)		3.3		
	Collector-Emitter On Voltage (V _{GE} = 15V, I _C = 50A, T _j = 25°C)		3.5		
I _{CES}	Collector Cut-off Current (V _{CE} = 1200V, V _{GE} = 0V, T _j = 25°C) ②		25	700	μΑ
	Collector Cut-off Current (V _{CE} = 1200V, V _{GE} = 0V, T _j = 125°C) ②		250		
I _{GES}	Gate-Emitter Leakage Current (V _{GE} = ±20V)			±250	nA

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

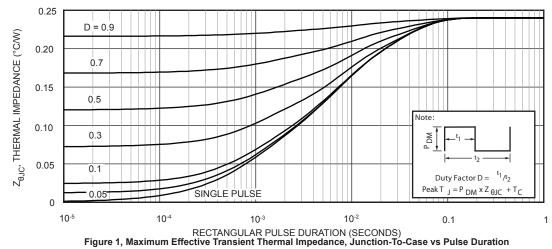
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
C _{ies}	Input Capacitance	Capacitance		2484		
C _{oes}	Output Capacitance	$V_{GE} = 0V, V_{CE} = 25V$		271		pF
C _{res}	Reverse Transfer Capacitance	f = 1MHz		75		
V_{GEP}	Gate to Emitter Plateau Voltage	Cata Charga		7.5		V
Q ^③	Total Gate Charge	Gate Charge		154	203	
Q _{ge}	Gate-Emitter Charge	V _{GE} = 15V		20	27	0
Q_{gc}	Gate- Collector Charge	$V_{CE} = 600V$ $I_{C} = 25A$		76	97	nC
t _{d(on)}	Turn-On Delay Time	Inductive Switching (25°C)		16		
t _r	Current Rise Time	V _{cc} = 600V		10		
t _{d(off)}	Turn-Off Delay Time	V _{GE} = 15V		122		ns
t _f	Current Fall Time	I _C = 25A		20		
E _{on2} ⑤	Turn-On Switching Energy	$R_{\rm G} = 4.3 \ \Omega^{(4)}$		434	650	1
E _{off}	Turn-Off Switching Energy	T _J = +25°C		466	700	μJ
t _{d(on)}	Turn-On Delay Time	Inductive Switching (125°C)		16		
t _r	Current Rise Time	V _{cc} = 600V		10		
t _{d(off)}	Turn-Off Delay Time	V _{GE} = 15V		136		ns
t _f	Current Fall Time	I _C = 25A		28		
E _{on2} 5	Turn-On Switching Energy	$R_{\rm g} = 4.3 \ \Omega^{(4)}$		506	760	1
E _{off}	Turn-Off Switching Energy	T _J = +125°C		480	720	μJ

THERMAL AND MECHANICAL CHARACTERISTICS

Symbol	Characteristic	Min	Тур	Max	Unit	
R _{eJC}	Junction to Case Thermal Resistance (IGBT)			.24		
	Junction to Case Thermal Resistance (Diode)			1.00	°C/W	
$R_{_{\theta JA}}$	Junction to Ambient Thermal Resistance			40	40	
W _T	Package Weight		.22		oz	
			6.2		g	
Torque	Terminals and Mounting Screws.			10	in·lbf	
				1.1	N·m	

- 1 Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- 2 Pulse test: Pulse Width < $380\mu s$, duty cycle < 2%.
- 3 See Mil-Std-750 Method 3471.
- $4~~R_{_{\mathrm{G}}}$ is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)
- 5 E_{on2} is the energy loss at turn-on and includes the charge stored in the freewheeling diode.
- 6 E_{off} is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1.

Microsemi reserves the right to change, without notice, the specifications and information contained herein.



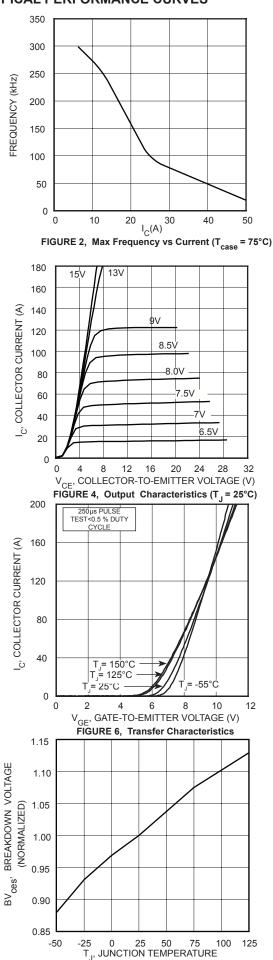
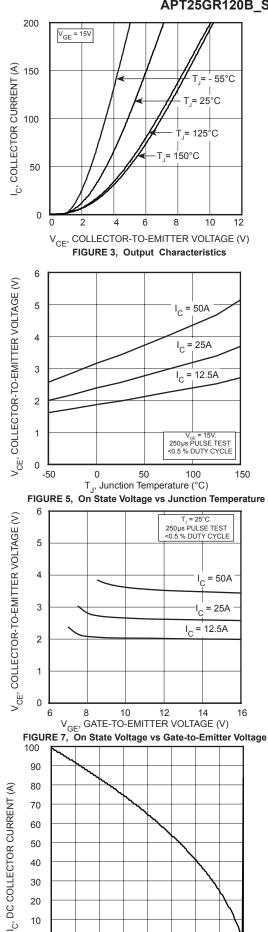


FIGURE 8, Breakdown Voltage vs Junction Temperature



20

10

0

-50

-25

25

50

T_C, Case Temperature (°C)

FIGURE 9, DC Collector Current vs Case Temperature

75 100 125 150

FIGURE 17, Minimum Switching Safe Operating Area

FIGURE 16, Energy Losses vs Junction Temperature

ZERO RECOVERY LOW LEAKAGE SIC ANTI-PARALLEL DIODE

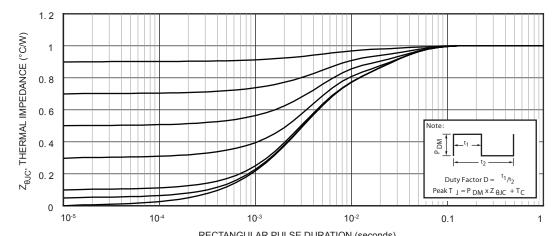
MAXIMUM RATINGS

All Ratings:	$T_{C} =$	25°C	unless	otherwise	specified.
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Symbol	Characteristic / Test Conditions		Ratings	Unit
	Maximum D.C. Famurand Comment	T _c = 25°C	36	
I _F	Maximum D.C. Forward Current $T_{c} = 135^{\circ}C$	10		
I _{FRM}	Repetitive Peak Forward Surge Current (T _J = 45°C, t _p = 10ms, Half Sine Wave)		50	Amps
I _{FSM}	Non-Repetitive Forward Surge Current (T _J = 25°C, t _p =	10ms, Half Sine)	110	

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions		Min	Тур	Max	Unit
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	Forward Voltage	I _F = 10A T _J = 25°C		1.5		Volta
V _F			2.1		Volts	
Q_c	Total Capactive Charge V_R = 800V, I_F = 10A, di/dt = -100A/ μ s, T_J = 25°C			30		nC
	Junction Capacitance $V_R = 0V$, $T_J = 25^{\circ}C$, $f = 1MHz$			600		
C _T	Junction Capacitance V _R = 200V, T _J = 25°C, f = 1MHz			71		pF
	Junction Capacitance V _R = 400V, T _J = 25°C, f = 1MHz			52		



RECTANGULAR PULSE DURATION (seconds)
FIGURE 18. MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs. PULSE DURATION

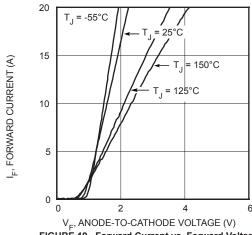


FIGURE 19, Forward Current vs. Forward Voltage

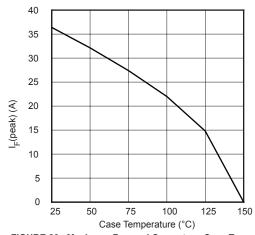


FIGURE 20, Maximum Forward Current vs. Case Temperature

TYPICAL PERFORMANCE CURVES

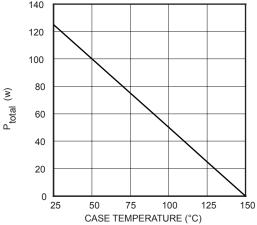
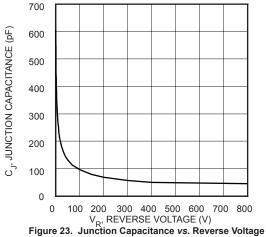


Figure 21. Maximum Power Dissipation vs. Case Temperature



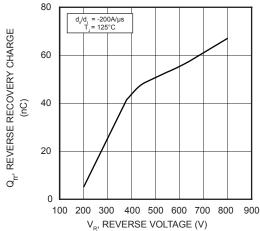
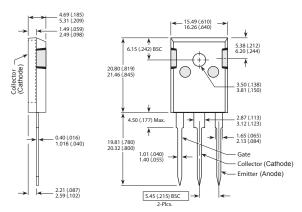


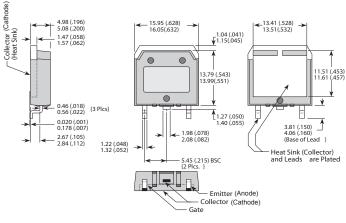
Figure 22. Reverse Recovery Charge vs. V_R

TO-247 Package Outline



Dimensions in Millimeters (Inches)

D³PAK Package Outline



Dimensions in Millimeters (Inches)

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